

GENERAL DESCRIPTION

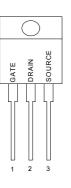
This high voltage MOSFET uses an advanced termination scheme to provide enhanced voltage-blocking capability without degrading performance over time. In addition, this advanced MOSFET is designed to withstand high energy in avalanche and commutation modes. The new energy efficient design also offers a drain-to-source diode with a fast recovery time. Designed for high voltage, high speed switching applications in power supplies, converters and PWM motor controls, these devices are particularly well suited for bridge circuits where diode speed and commutating safe operating areas are critical and offer additional and safety margin against unexpected voltage transients.

FEATURES

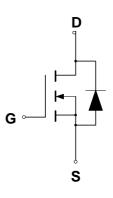
- Robust High Voltage Termination
- Avalanche Energy Specified
- Source-to-Drain Diode Recovery Time Comparable to a Discrete Fast Recovery Diode
- Diode is Characterized for Use in Bridge Circuits
- I_{DSS} Specified at Elevated Temperature

PIN CONFIGURATION

TO-220/TO-220FP Front View



SYMBOL



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS

Rating		Value	Unit	
Drain to Current – Continuous		7.0	А	
 Pulsed 	I _{DM}	20		
Gate-to-Source Voltage — Continue		±20	V	
 Non-repetitive 	V_{GSM}	±40	V	
Total Power Dissipation	PD		W	
TO-220		147		
TO-220FP		50		
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to 150	°C	
Single Pulse Drain-to-Source Avalanche Energy $-$ T _J = 25 $^{\circ}$ C		245	mJ	
$(V_{DD} = 100V, V_{GS} = 10V, I_{L} = 7A, L = 10mH, R_{G} = 25\Omega)$				
Thermal Resistance – Junction to Case	θ_{JC}	1.0	°C <i>I</i> W	
 Junction to Ambient 	θ_{JA}	62.5		
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	TL	260	°C	

(1) VDD = 50V, ID = 10A

(2) Pulse Width and frequency is limited by TJ(max) and thermal response



ORDERING INFORMATION

Part Number	Package	
CMT07N60	TO-220	
CMT07N60FP	TO-220 Full Pak	

ELECTRICAL CHARACTERISTICS

Unless otherwise specified, T_J = 25 $^\circ\!\mathrm{C}$.

			CMT07N60			
Characteristic		Symbol	Min	Тур	Max	Units
Drain-Source Breakdown Voltage		V _{(BR)DSS}	600			V
$(V_{GS} = 0 V, I_{D} = 250 \mu A)$						
Drain-Source Leakage Current		I _{DSS}				μA
$(V_{DS} = 600 \text{ V}, \text{ V}_{GS} = 0 \text{ V})$					100	
$(V_{DS} = 480 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125^{\circ}\text{C})$					100	
Gate-Source Leakage Current-Forward		I _{GSSF}			100	nA
$(V_{gsf} = 20 \text{ V}, V_{DS} = 0 \text{ V})$						
Gate-Source Leakage Current-Revers	Gate-Source Leakage Current-Reverse				100	nA
$(V_{gsr} = 20 \text{ V}, V_{DS} = 0 \text{ V})$						
Gate Threshold Voltage		$V_{GS(th)}$	2.0		4.0	V
$(V_{DS} = V_{GS}, I_D = 250 \ \mu A)$						
Static Drain-Source On-Resistance (V	_{GS} = 10 V, I _D = 3.5A) *	R _{DS(on)}			1.2	Ω
Forward Transconductance (V _{DS} = 40	V, I _D = 3.5A) *	g _{FS}	4.0			mhos
Input Capacitance	$(V_{DS} = 25 V, V_{GS} = 0 V,$	C _{iss}		1380	1800	pF
Output Capacitance	f = 1.0 MHz	C _{oss}		115	150	pF
Reverse Transfer Capacitance	1 – 1.0 Wi 12)	C _{rss}		23	30	pF
Turn-On Delay Time	(V _{DD} = 300 V, I _D = 7.0 A,	t _{d(on)}		30	70	ns
Rise Time	$(V_{DD} = 300 \text{ V}, \text{ I}_D = 7.0 \text{ A},$ $V_{GS} = 10 \text{ V},$ $R_G = 9.1\Omega) *$	tr		80	170	ns
Turn-Off Delay Time		t _{d(off)}		125	260	ns
Fall Time		t _f		85	180	ns
Total Gate Charge	$(V_{DS} = 480 \text{ V}, I_D = 7.0 \text{ A}, V_{GS} = 10 \text{ V})^*$	Qg		38	50	nC
Gate-Source Charge		Q_gs		6.4		nC
Gate-Drain Charge		Q_gd		15		nC
Internal Drain Inductance		L _D		4.5		nH
(Measured from the drain lead 0.25"	from package to center of die)					
Internal Drain Inductance		Ls		7.5		nH
(Measured from the source lead 0.2	5" from package to source bond pad)					
SOURCE-DRAIN DIODE CHARACTE	RISTICS					
Forward On-Voltage(1)	(I _S =7.0 A,	V _{SD}			1.4	V
Forward Turn-On Time		t _{on}		**		ns
Reverse Recovery Time	d _{IS} /d _t = 100A/µs)	t _{rr}		415		ns

* Pulse Test: Pulse Width \leq 300µs, Duty Cycle \leq 2%

** Negligible, Dominated by circuit inductance



TYPICAL ELECTRICAL CHARACTERISTICS

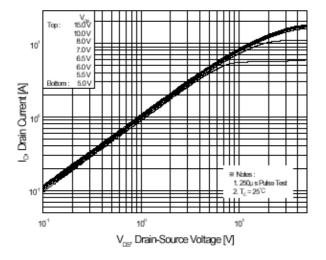
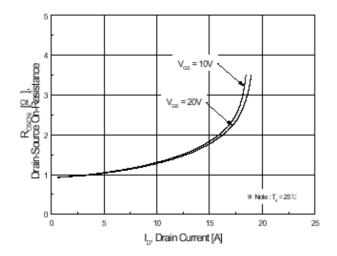
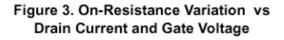


Figure 1. On-Region Characteristics





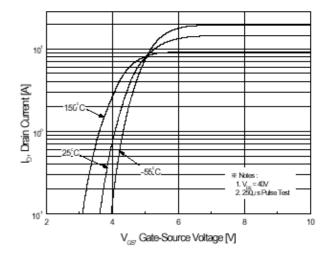


Figure 2. Transfer Characteristics

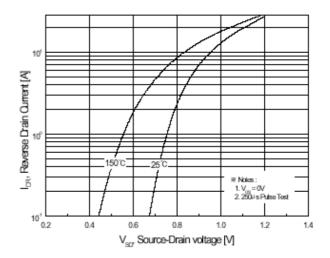


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature



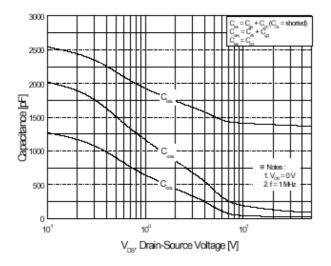


Figure 5. Capacitance Characteristics

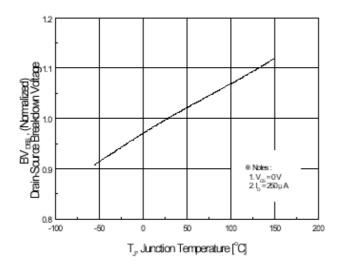


Figure 7. Breakdown Voltage Variation vs Temperature

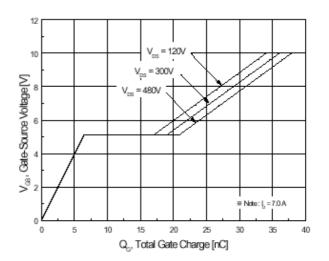


Figure 6. Gate Charge Characteristics

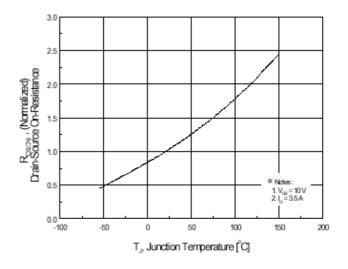
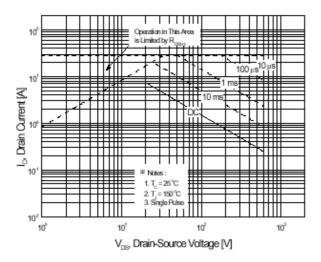


Figure 8. On-Resistance Variation





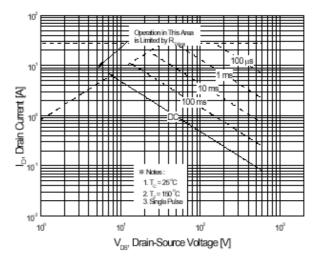
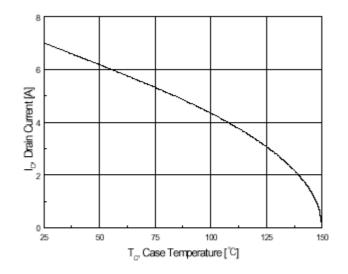
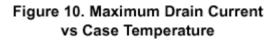


Figure 9-1. Maximum Safe Operating Area

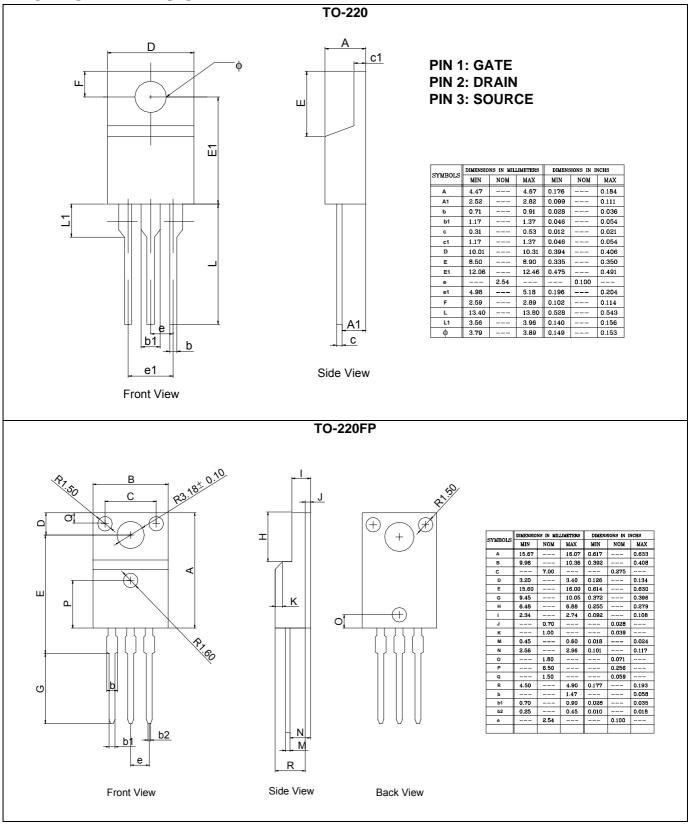
Figure 9-2. Maximum Safe Operating Area







PACKAGE DIMENSION





IMPORTANT NOTICE

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